Application/Control No. Applicant(s)/Patent Under Reexamination 10/516,786 EDELER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 **Kiet Doan** 2617 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,961,591 B2 11-2005 Osano, Keiji Α 455/569.1 08-2002 US-6,430,217 B1 Suzuki et al. В 375/219 US-6,203,344 B1 03-2001 С Ito, Akashi 439/218 US-D Ε US-US-F US-G US-Н US-1 US-J USκ US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification. Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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